


<b>Search Notes</b> 	<b>Application/Control No.</b> 10591107	<b>Applicant(s)/Patent Under Reexamination</b> LIU, ENHUI
	<b>Examiner</b> Joey Bednash	<b>Art Unit</b> 2461

SEARCHED			
Class	Subclass	Date	Examiner
370	389	6/30/2010	Joey Bednash
709	223	6/30/2010	Joey Bednash

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search in eDAN	6/30/2010	Joey Bednash
EAST search history attached	6/30/2010	Joey Bednash

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/Joey Bednash/  
Examiner, Art Unit 2461